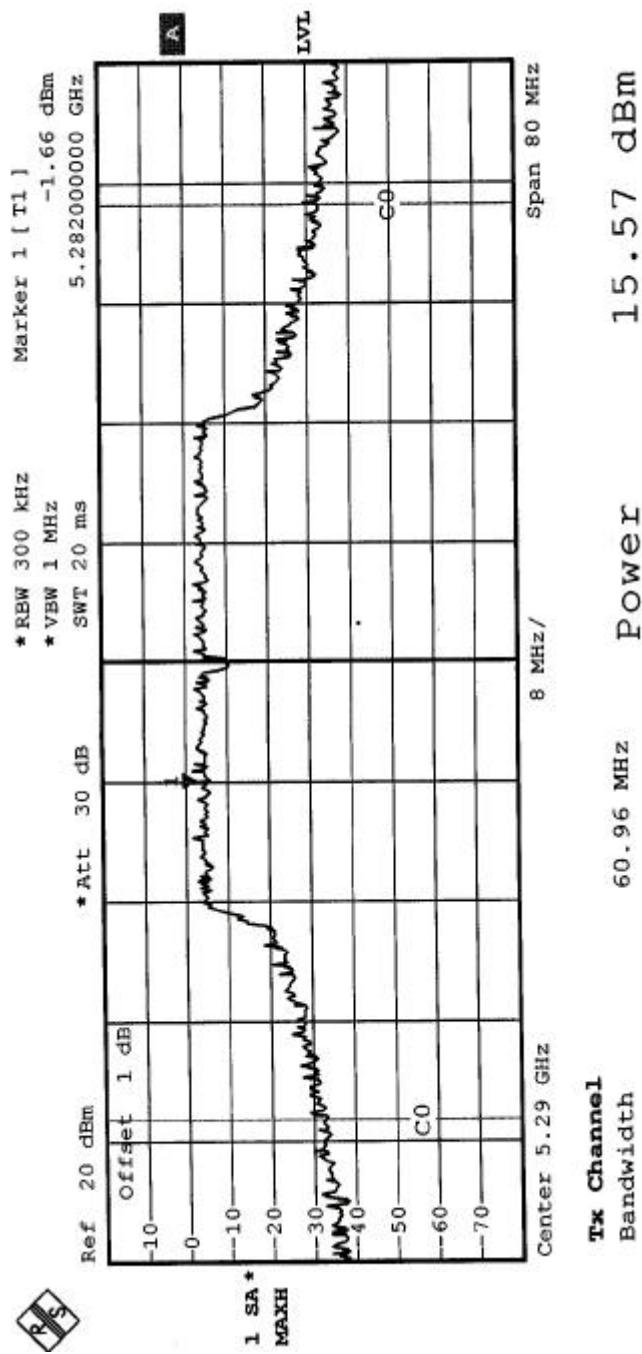
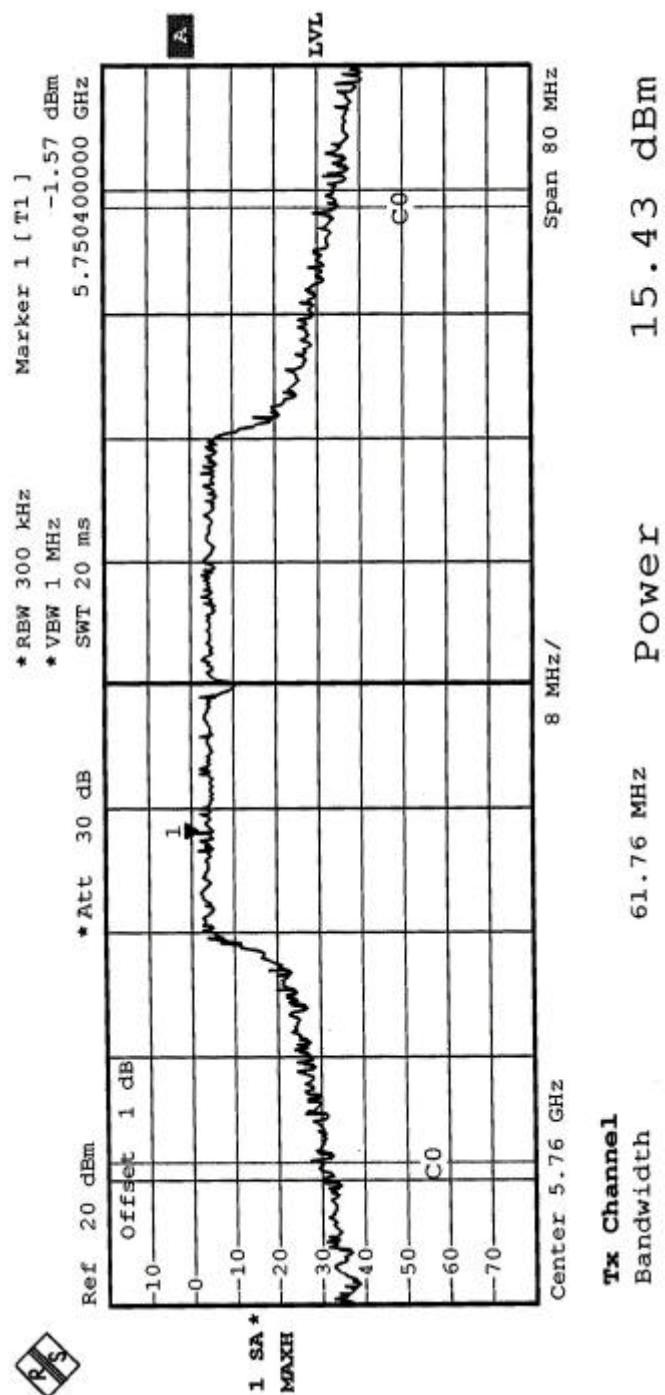


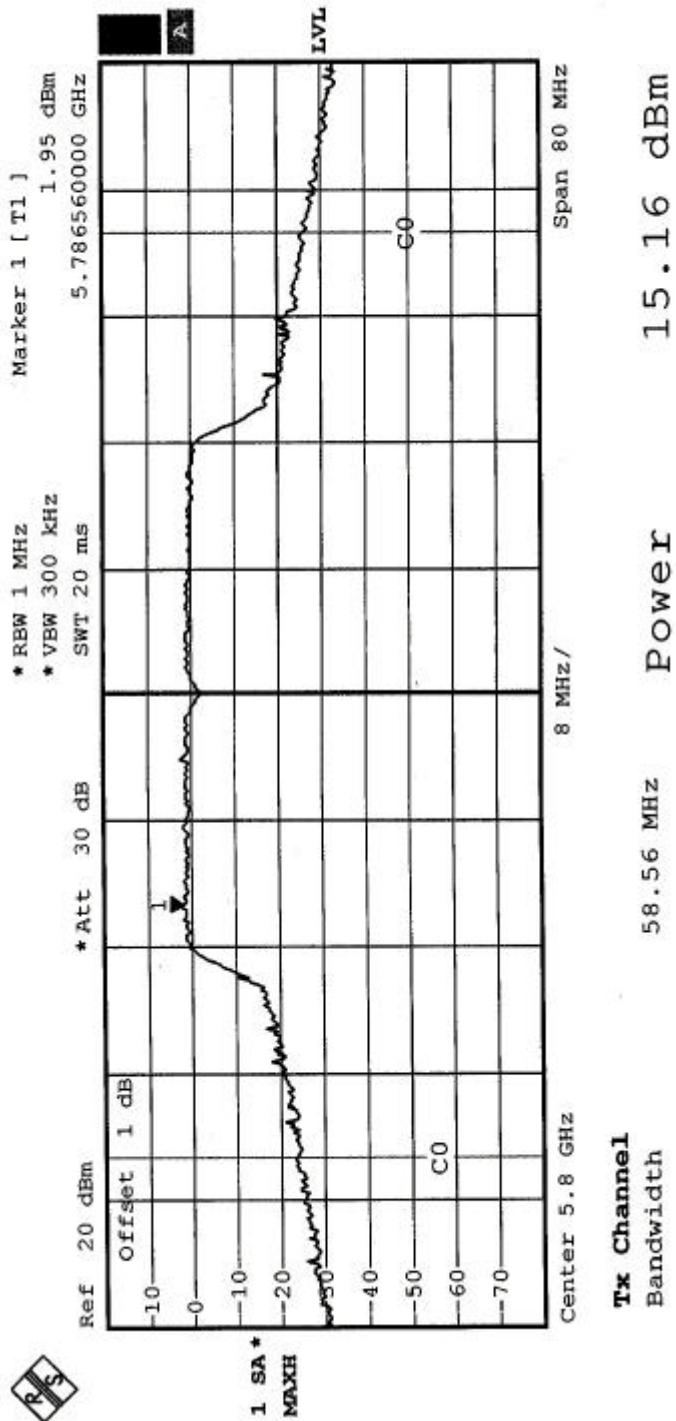
CHANNEL 3



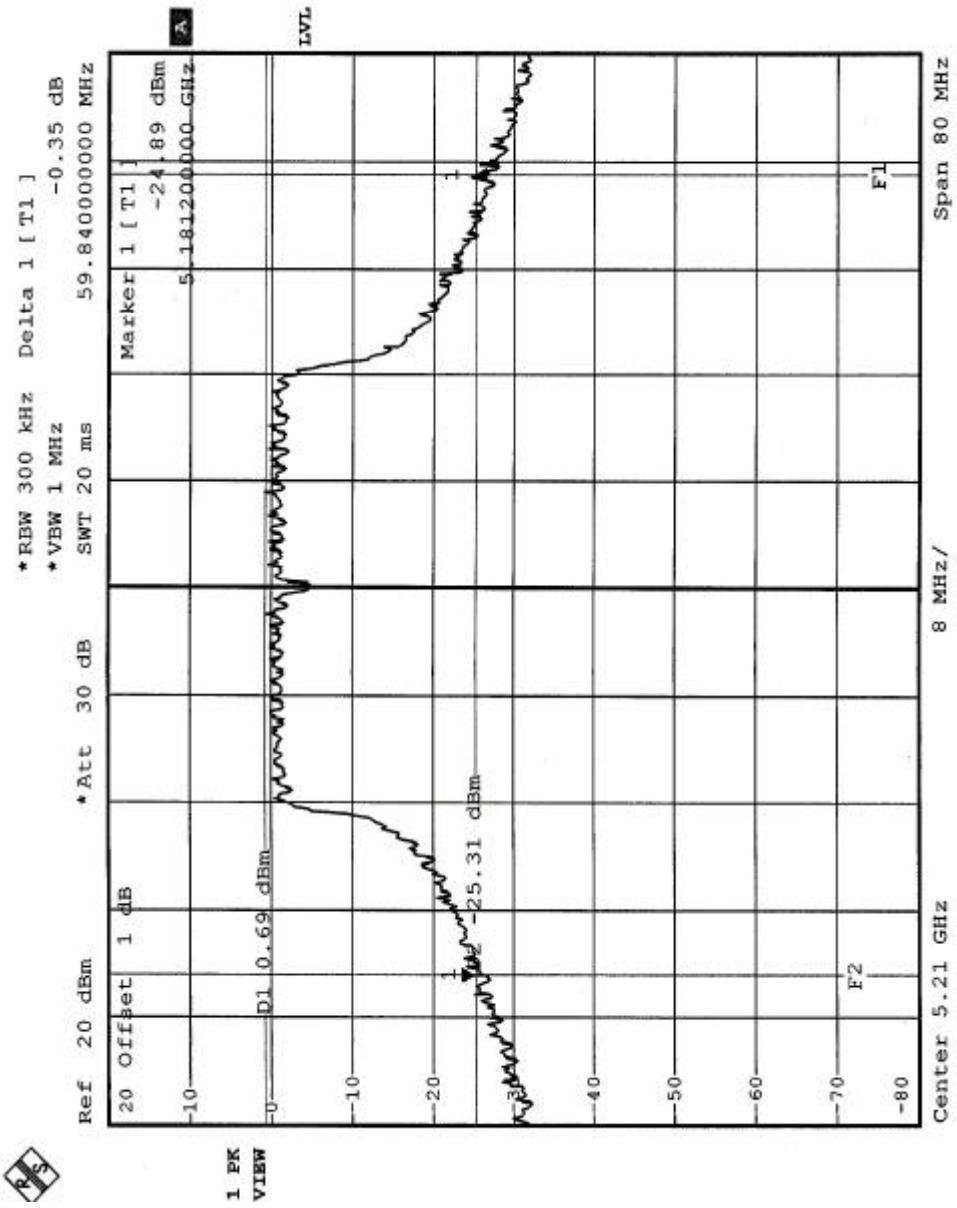
CHANNEL 4



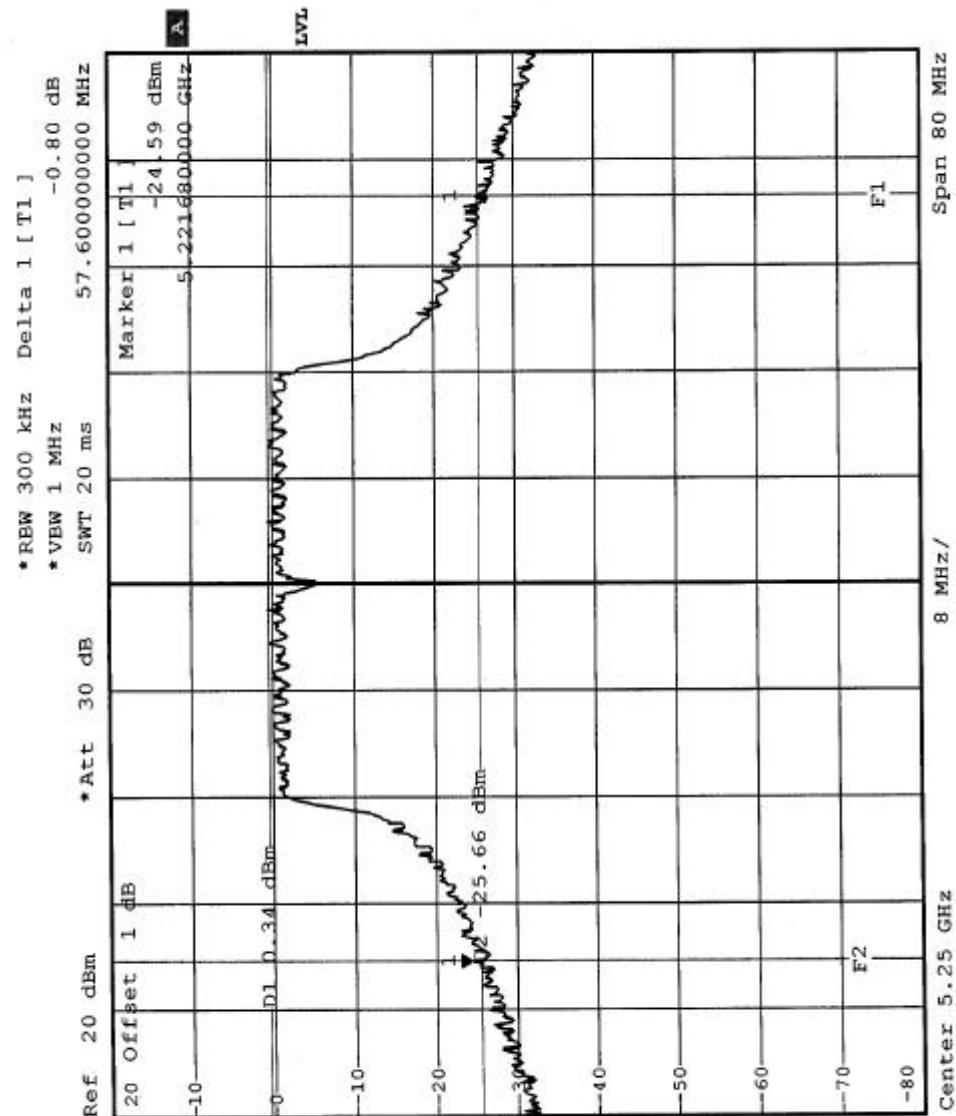
CHANNEL 5



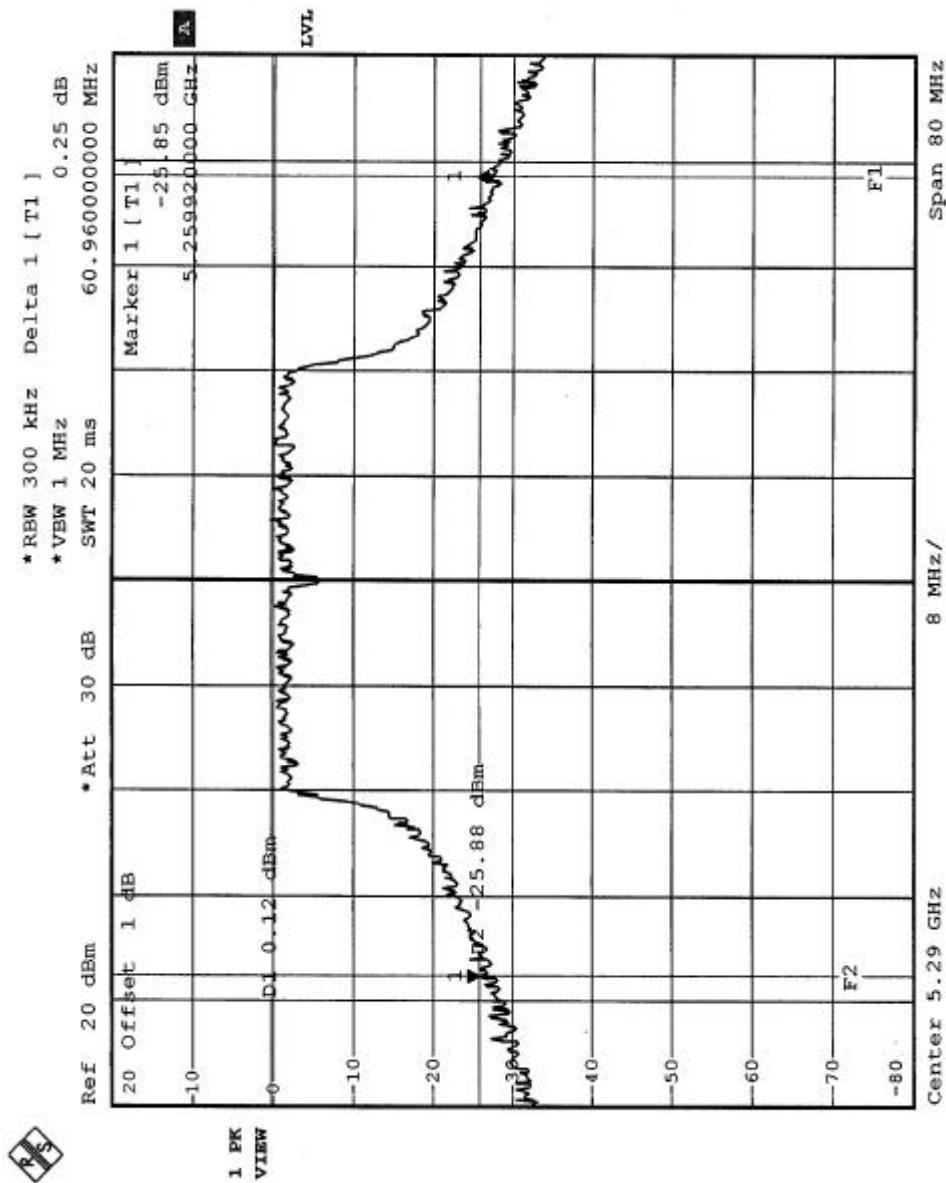
CHANNEL 1



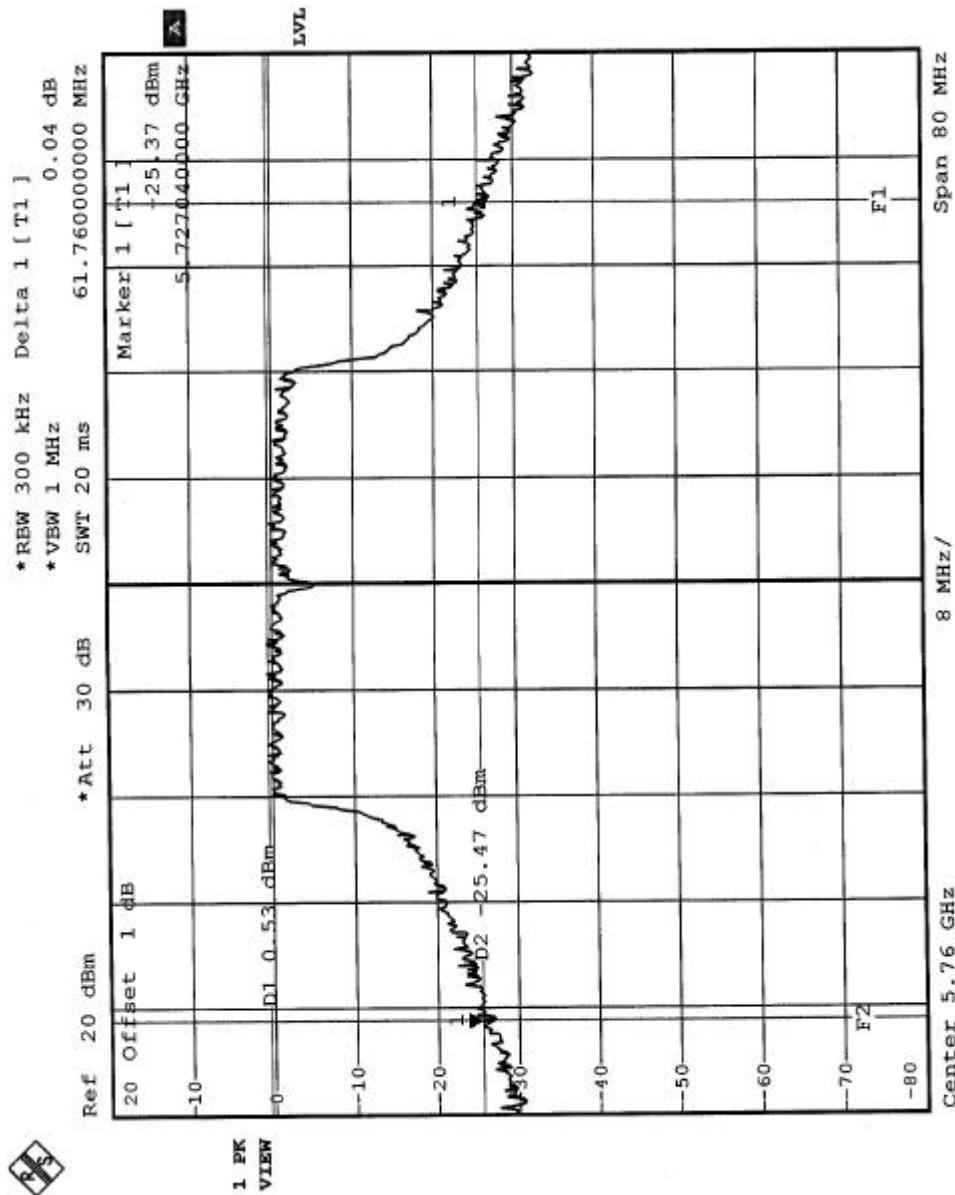
CHANNEL 2



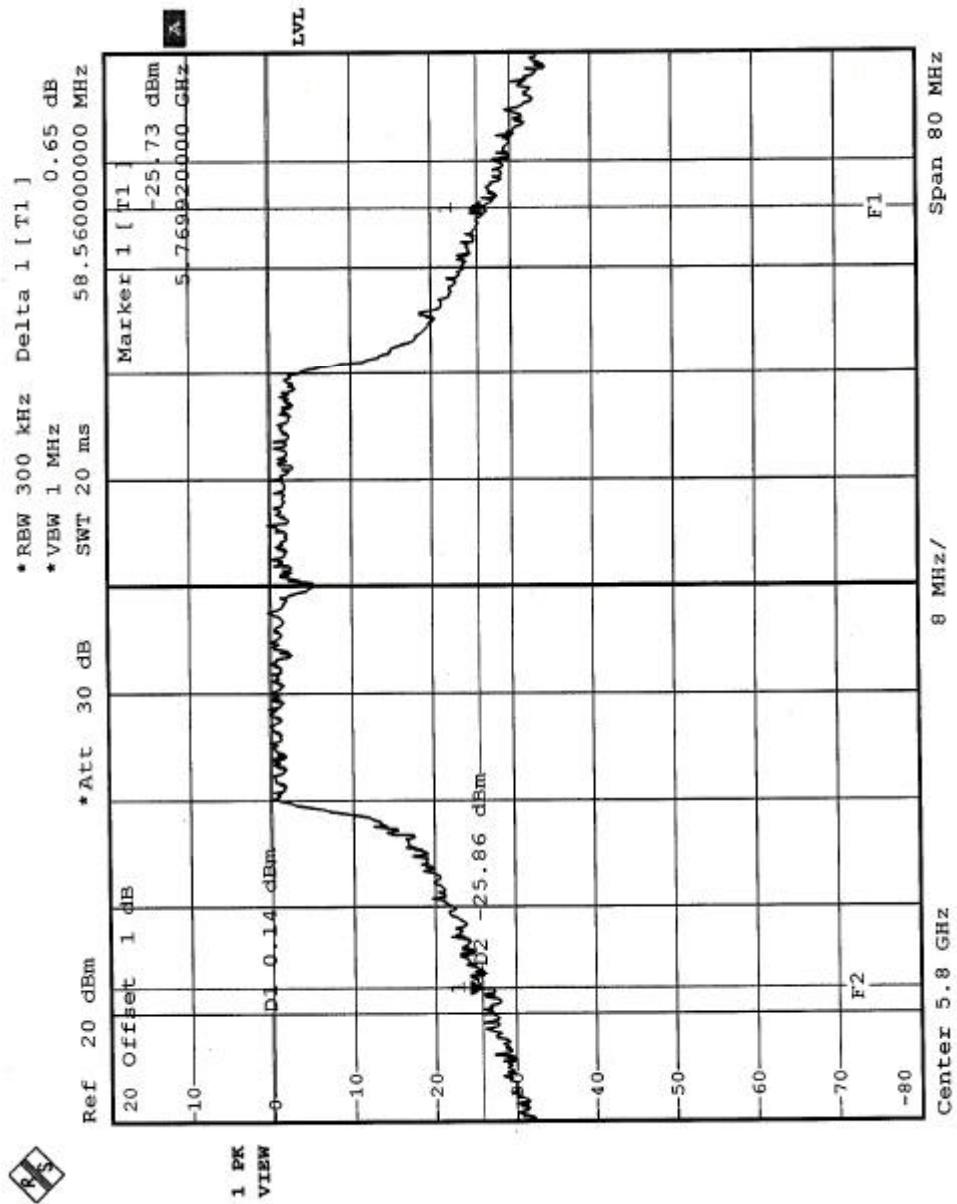
CHANNEL 3



CHANNEL 4



CHANNEL 5



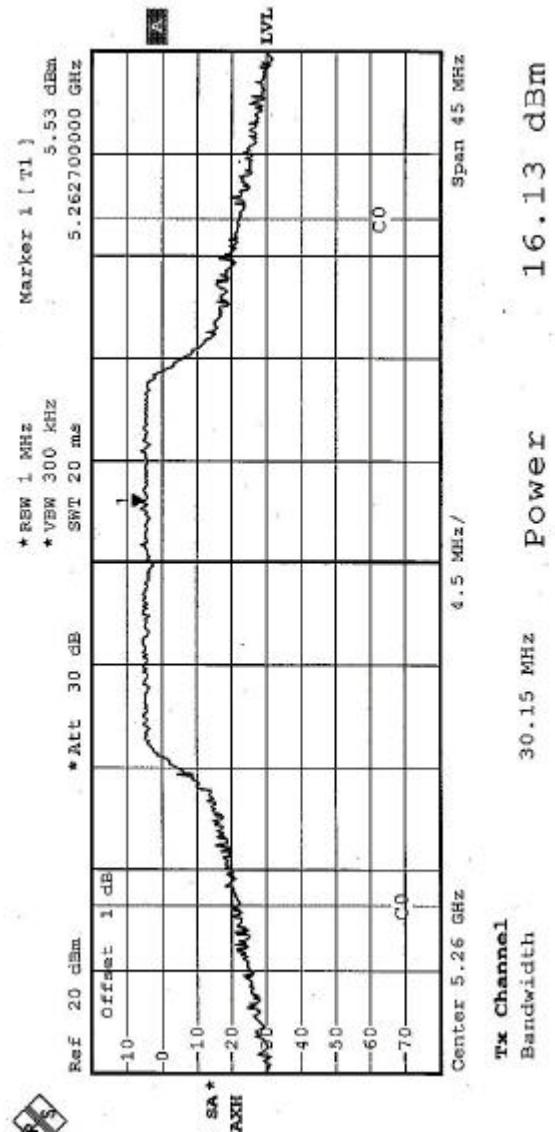
5.3.7 TEST RESULTS (B)

EUT	Wireless LAN Access Point	MODEL	A300-2
MODE	Normal	INPUT POWER (SYSTEM)	120Vac, 60 Hz
ENVIRONMENTAL CONDITIONS	21eg. C, 58RH, 976 hPa	TESTED BY	Eric Lee

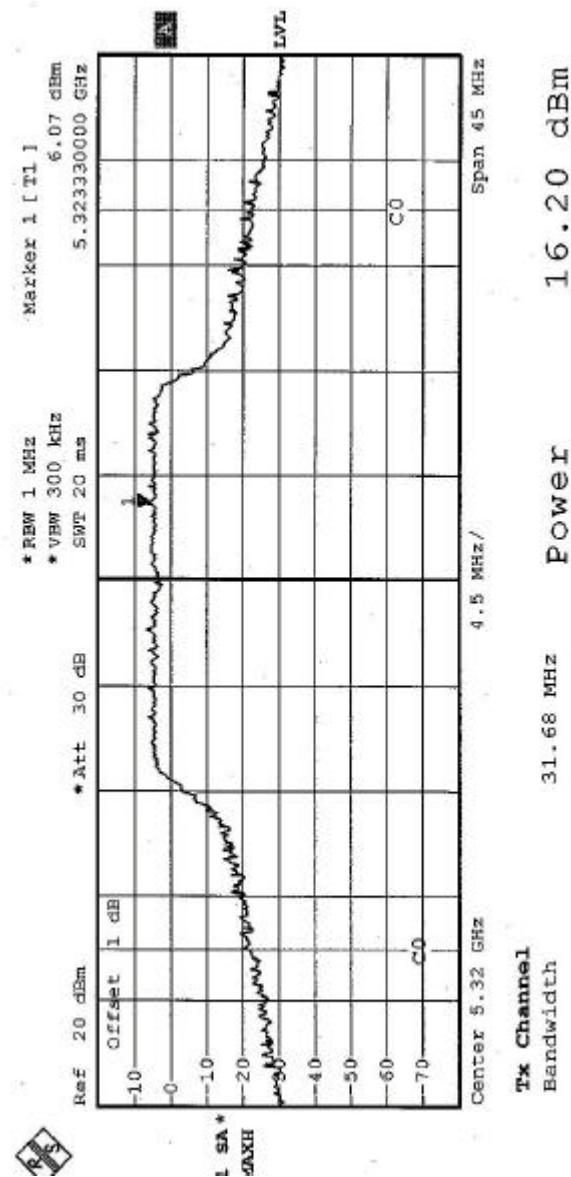
CHANNEL	CHANNEL FREQUENCY (MHz)	PEAK POWER OUTPUT (dBm)	PEAK POWER LIMIT (dBm)	26dBc Occupied Bandwidth (MHz)	PASS/FAIL
5	5260	16.13	24.00	30.15	PASS
8	5320	16.2	24.00	31.68	PASS
9	5745	16.86	30.00	32.94	PASS
12	5805	16.86	30.00	38.61	PASS

NOTE: The 26dBc Occupied Bandwidth plot, please refer to the following pages.

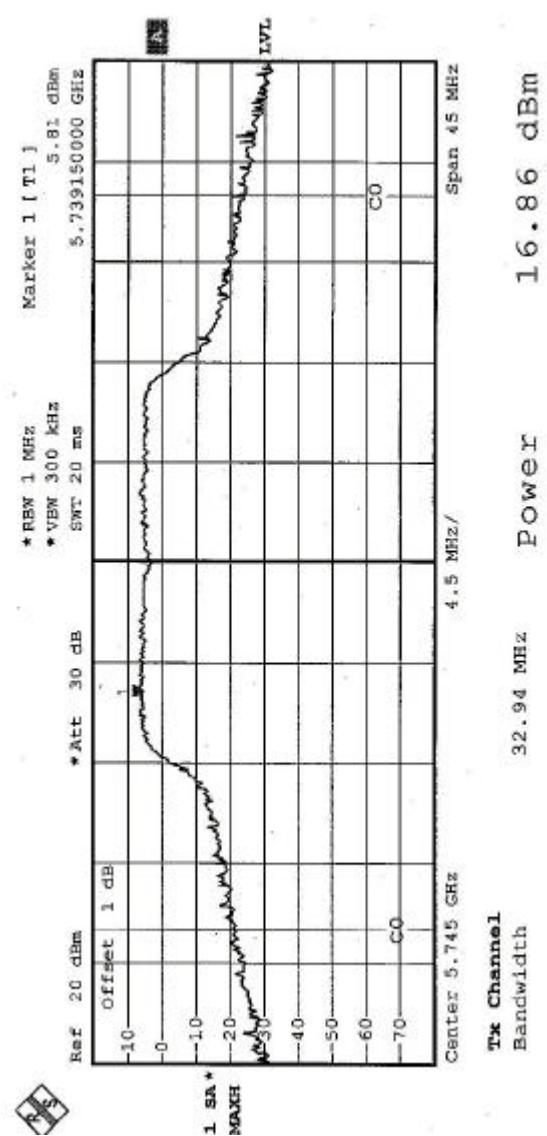
CHANNEL 5



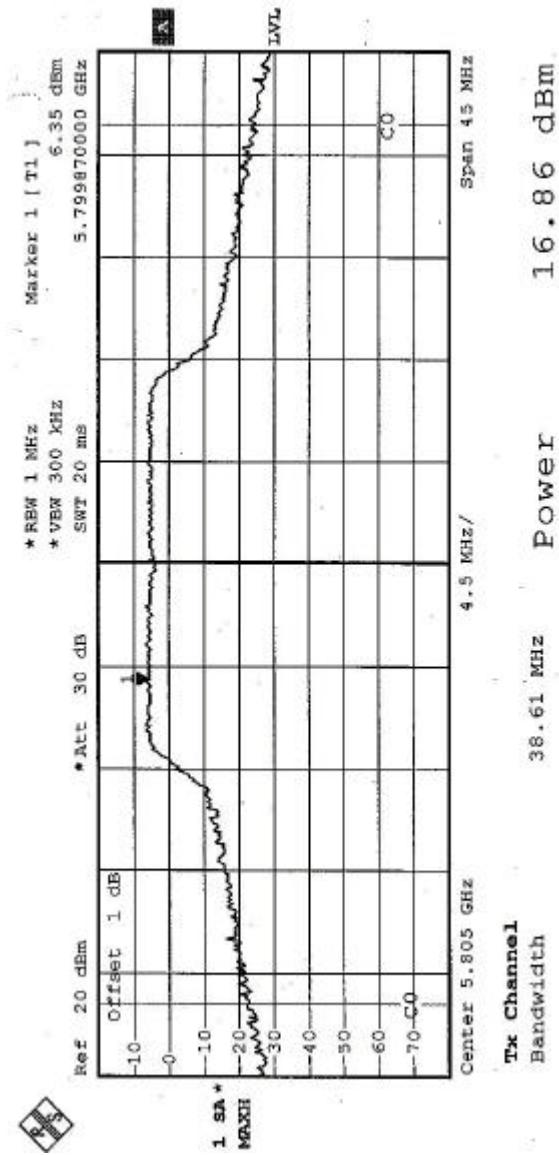
CHANNEL 8



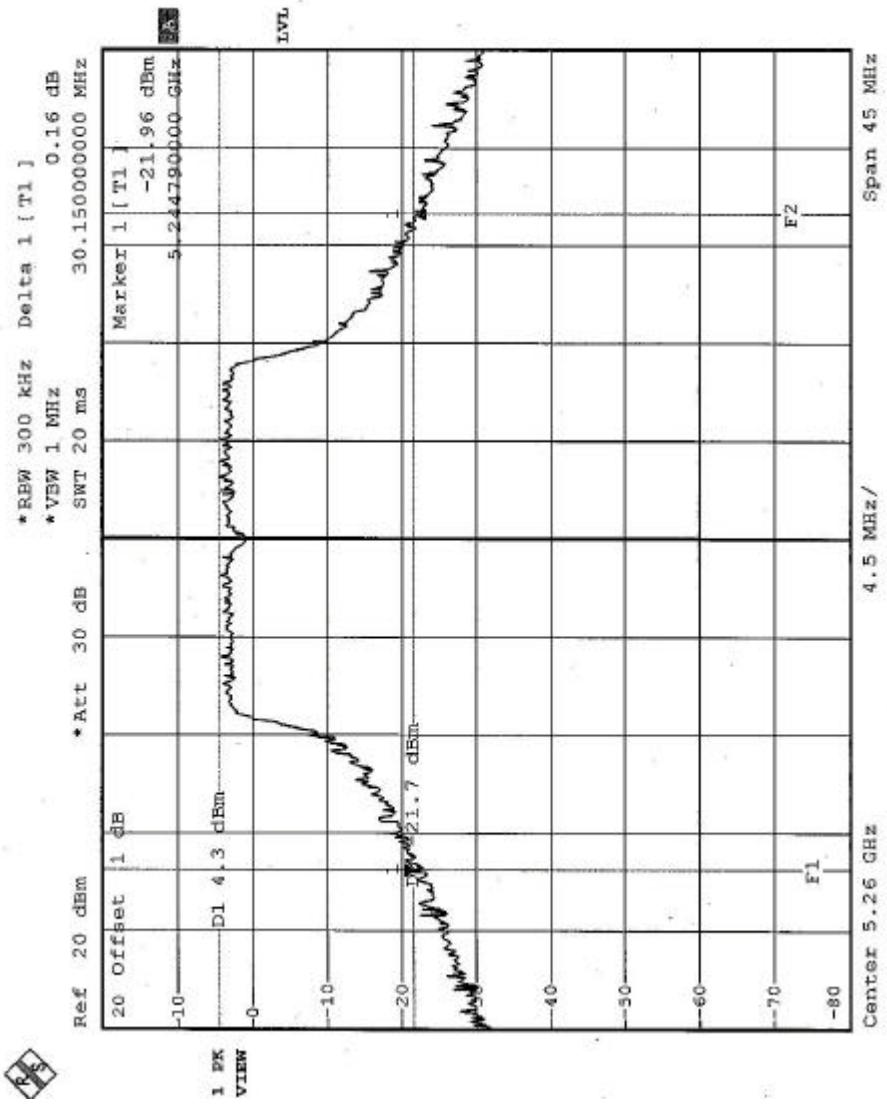
CHANNEL 9



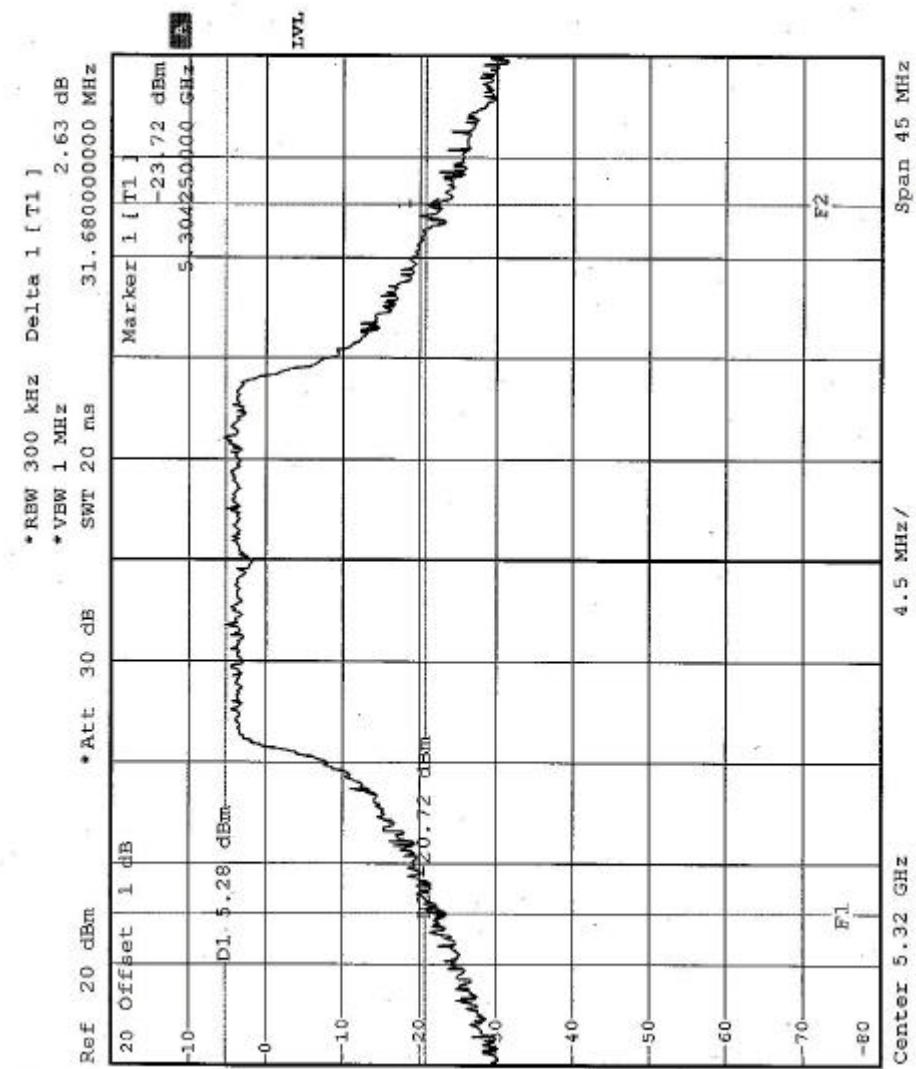
CHANNEL 12



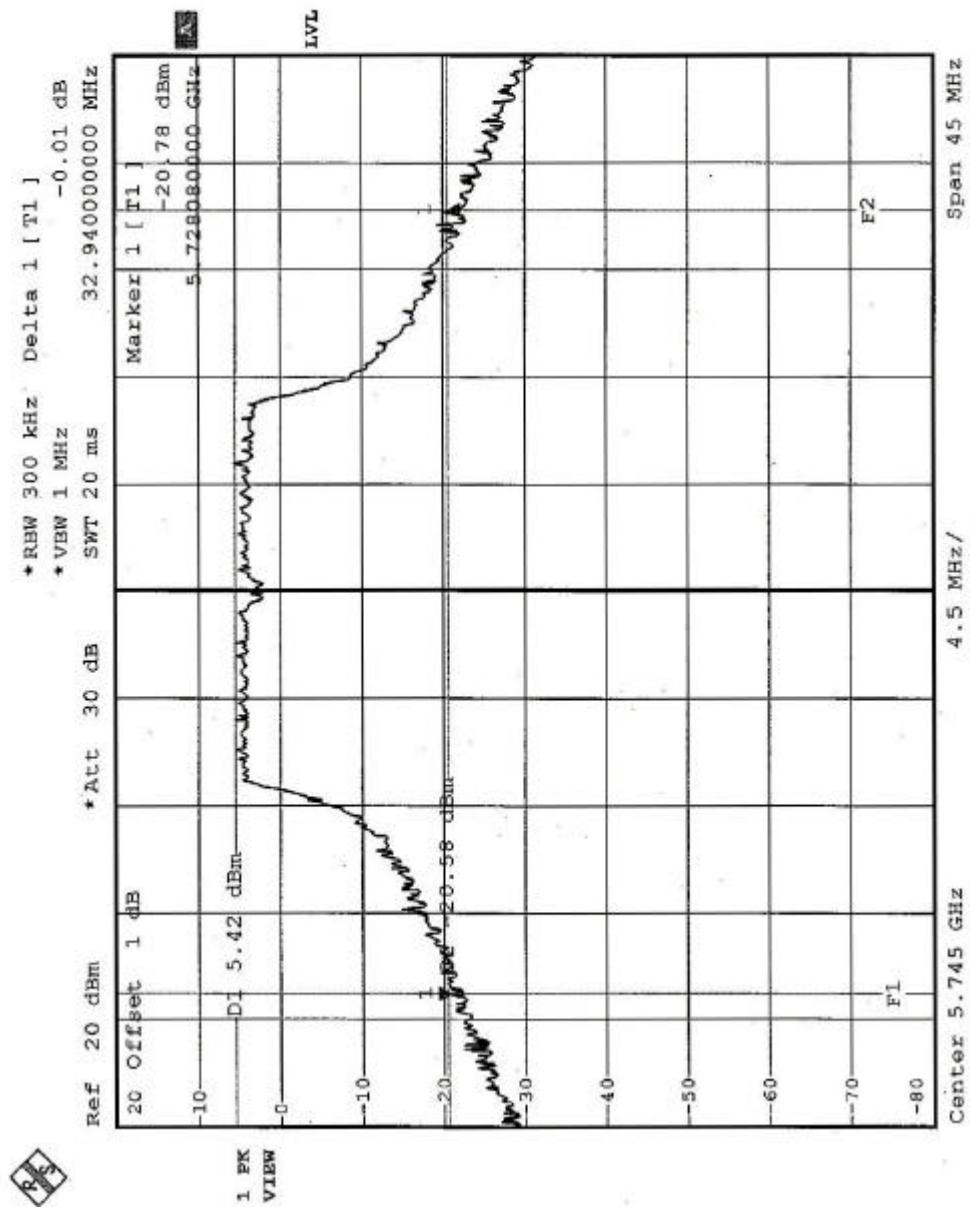
CHANNEL 5



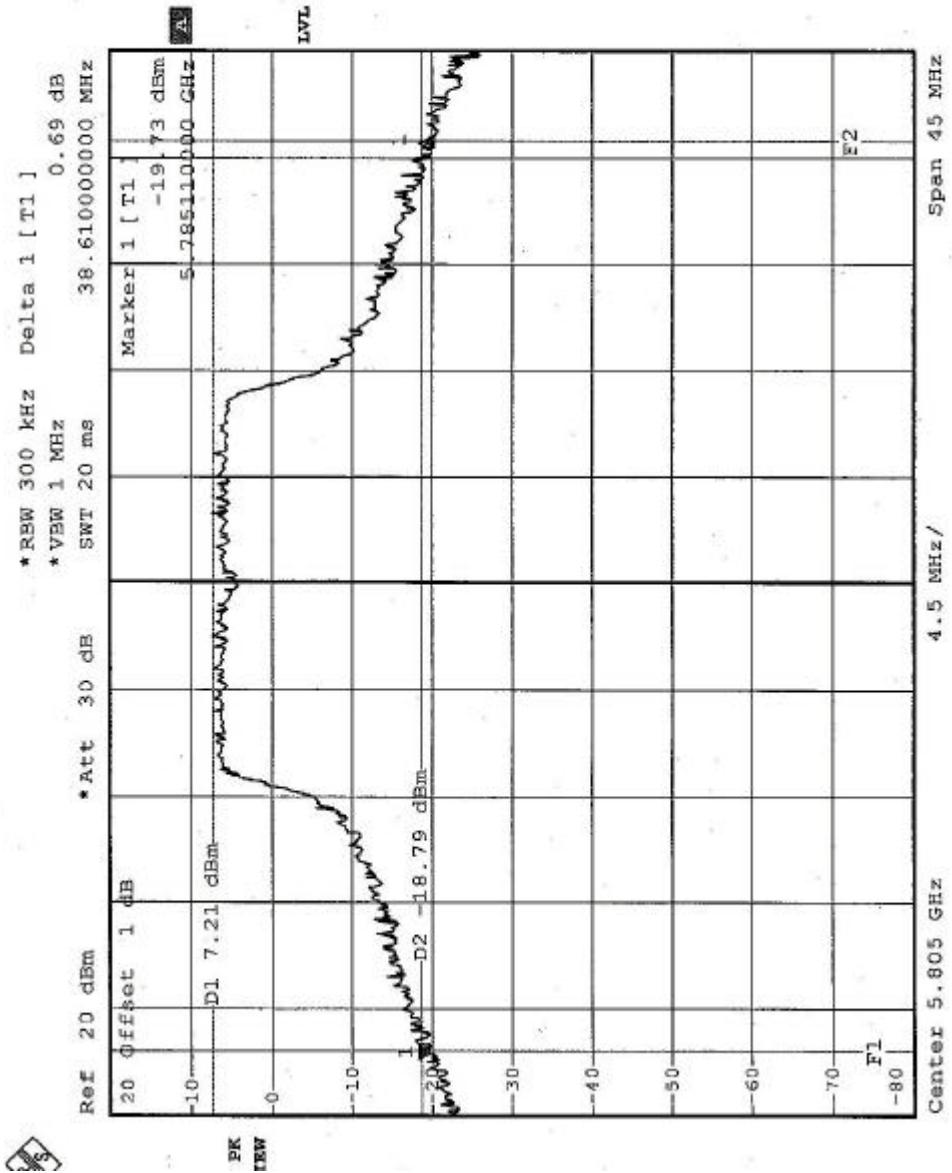
CHANNEL 8



CHANNEL9



CHANNEL 12

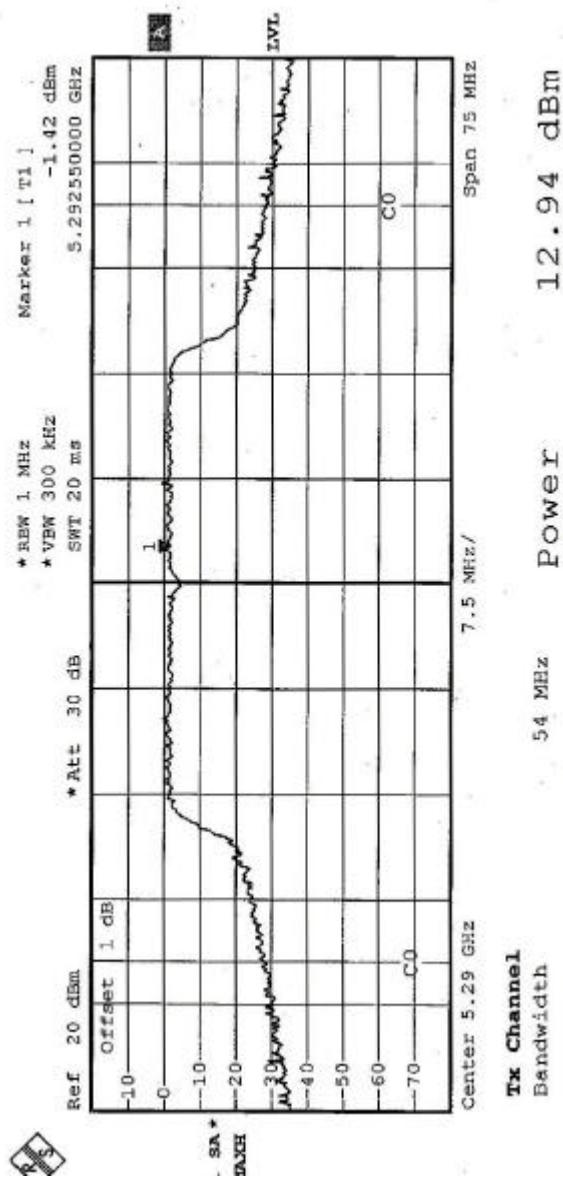


EUT	Wireless LAN Access Point	MODEL	A300-2
MODE	Turbo	INPUT POWER (SYSTEM)	120Vac, 60 Hz
ENVIRONMENTAL CONDITIONS	25eg. C, 66RH, 976 hPa	TESTED BY	Eric Lee

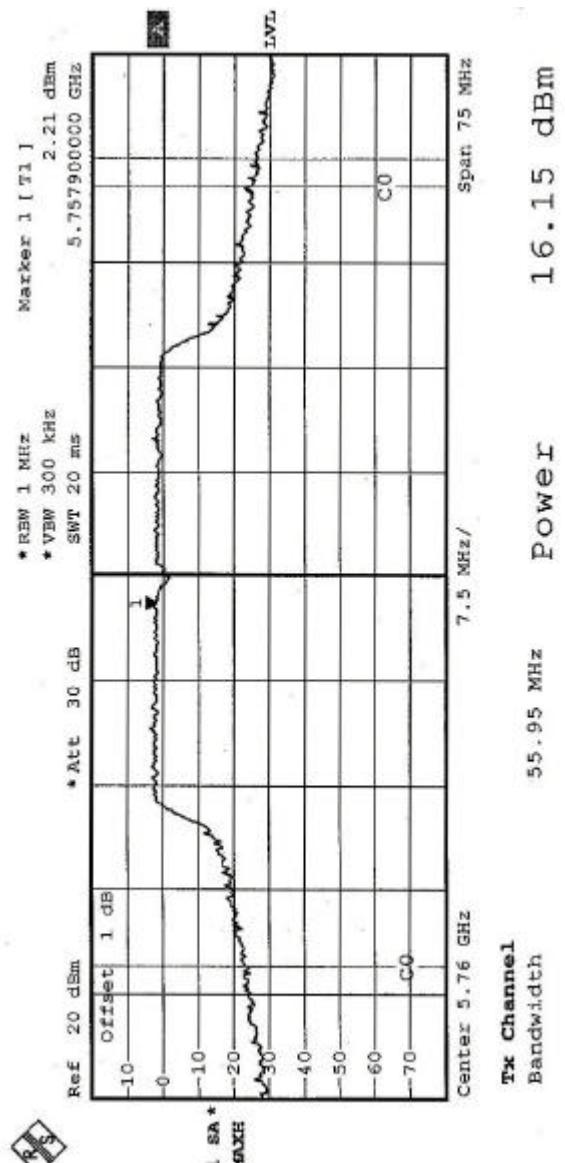
CHANNEL	CHANNEL FREQUENCY (MHz)	PEAK POWER OUTPUT (dBm)	PEAK POWER LIMIT (dBm)	26dBc Occupied Bandwidth (MHz)	PASS/FAIL
3	5290	12.94	24.00	54.50	PASS
4	5760	16.15	30.00	55.95	PASS
5	5800	16.15	30.00	61.35	PASS

NOTE: The 26dBc Occupied Bandwidth plot, please refer to the following pages.

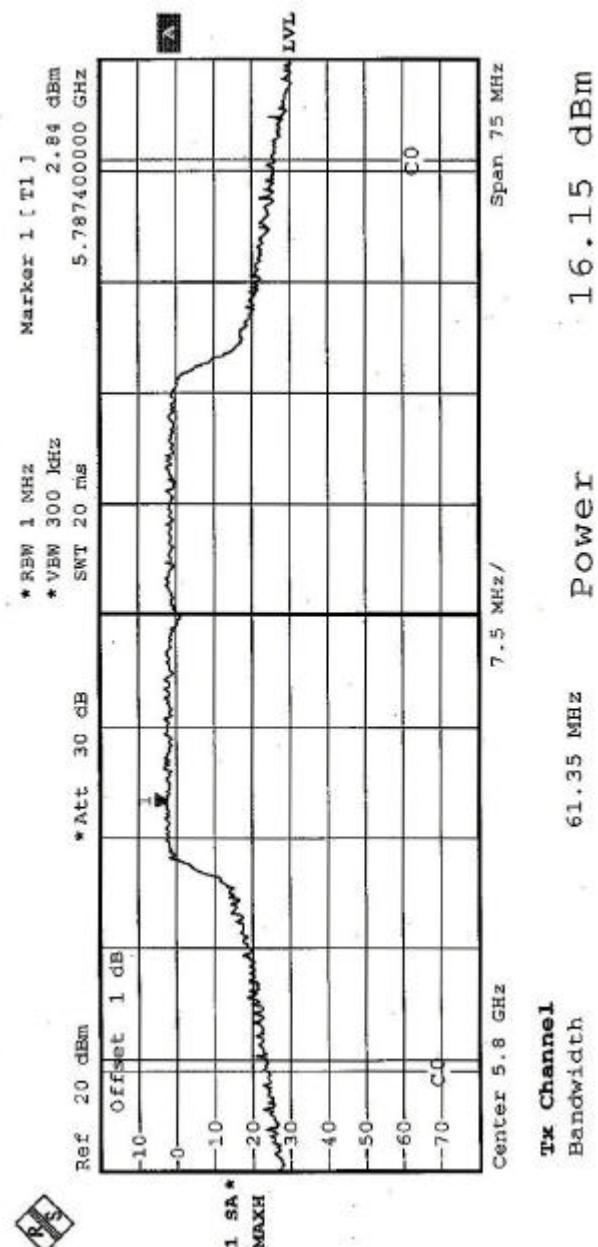
CHANNEL 3



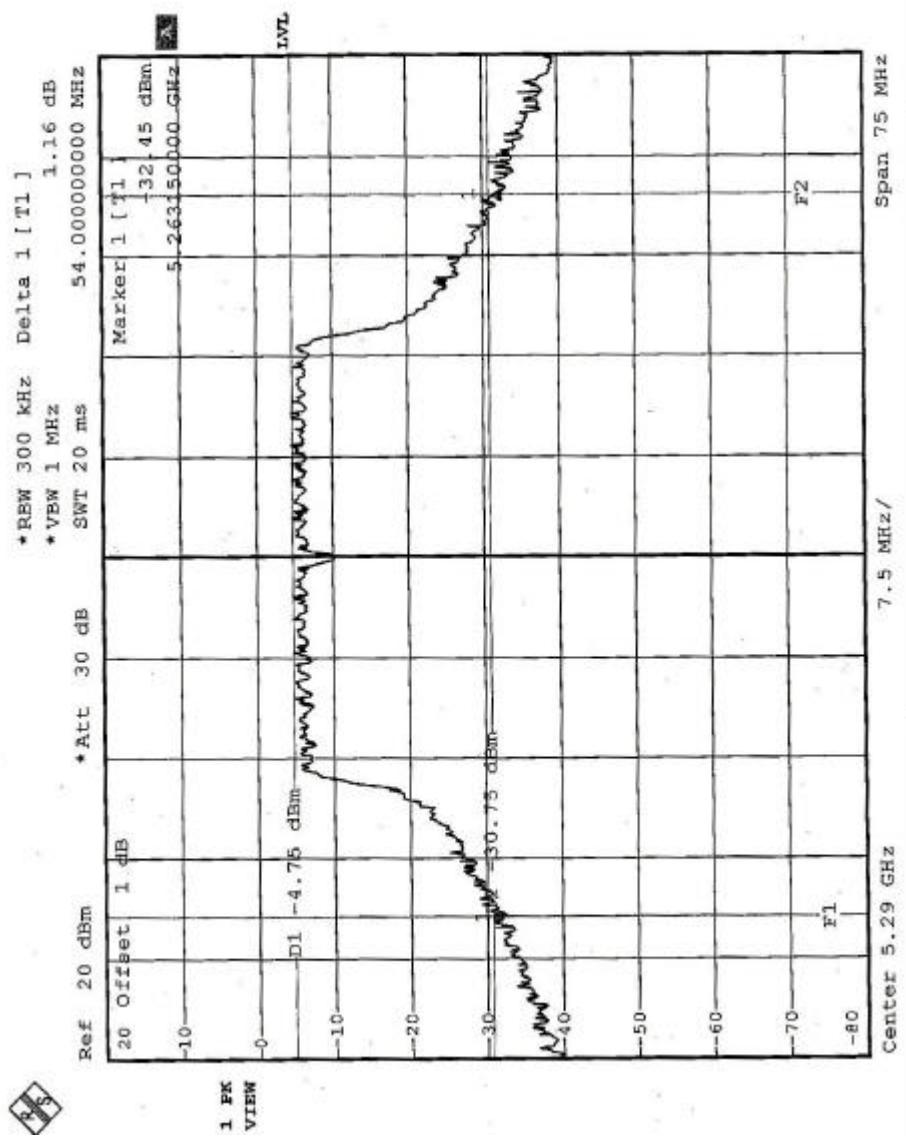
CHANNEL 4



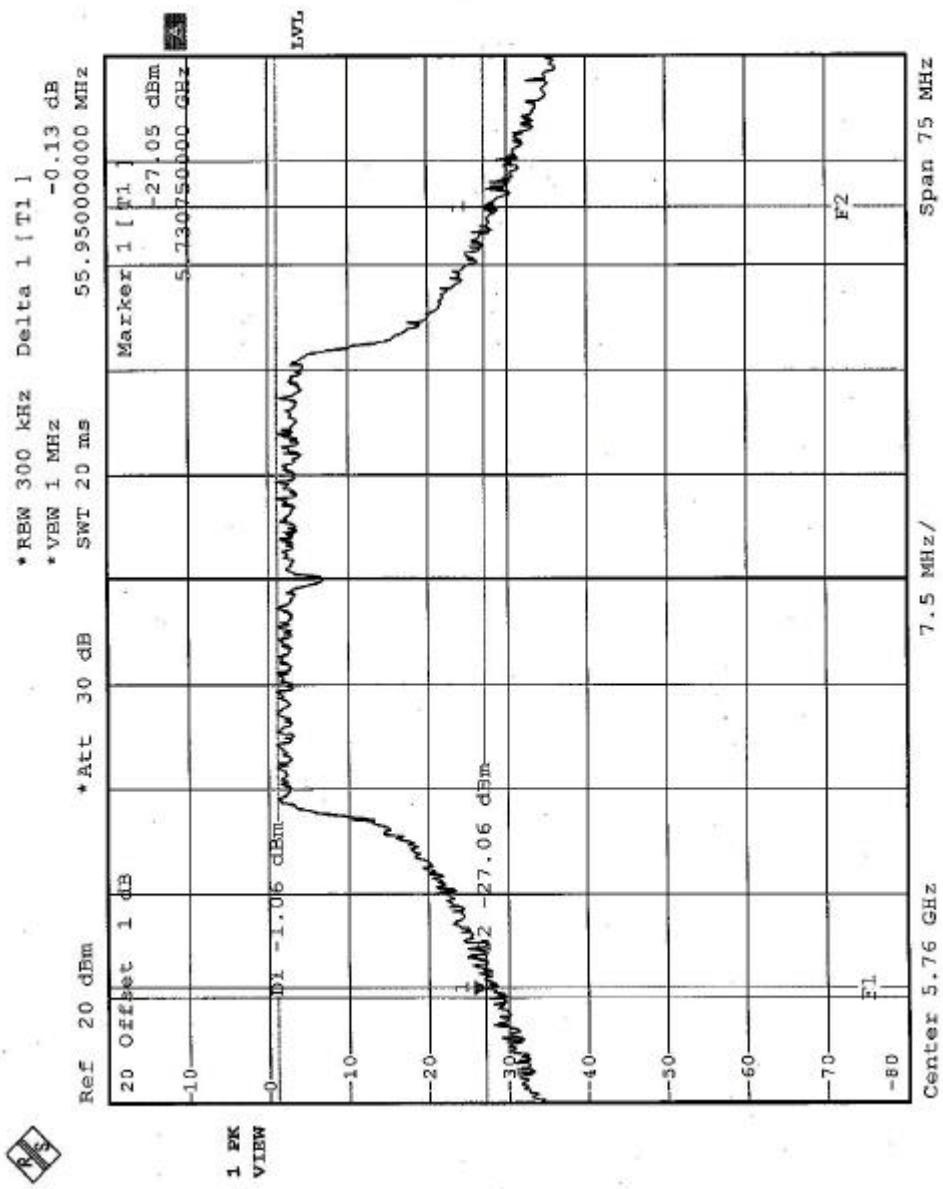
CHANNEL 5



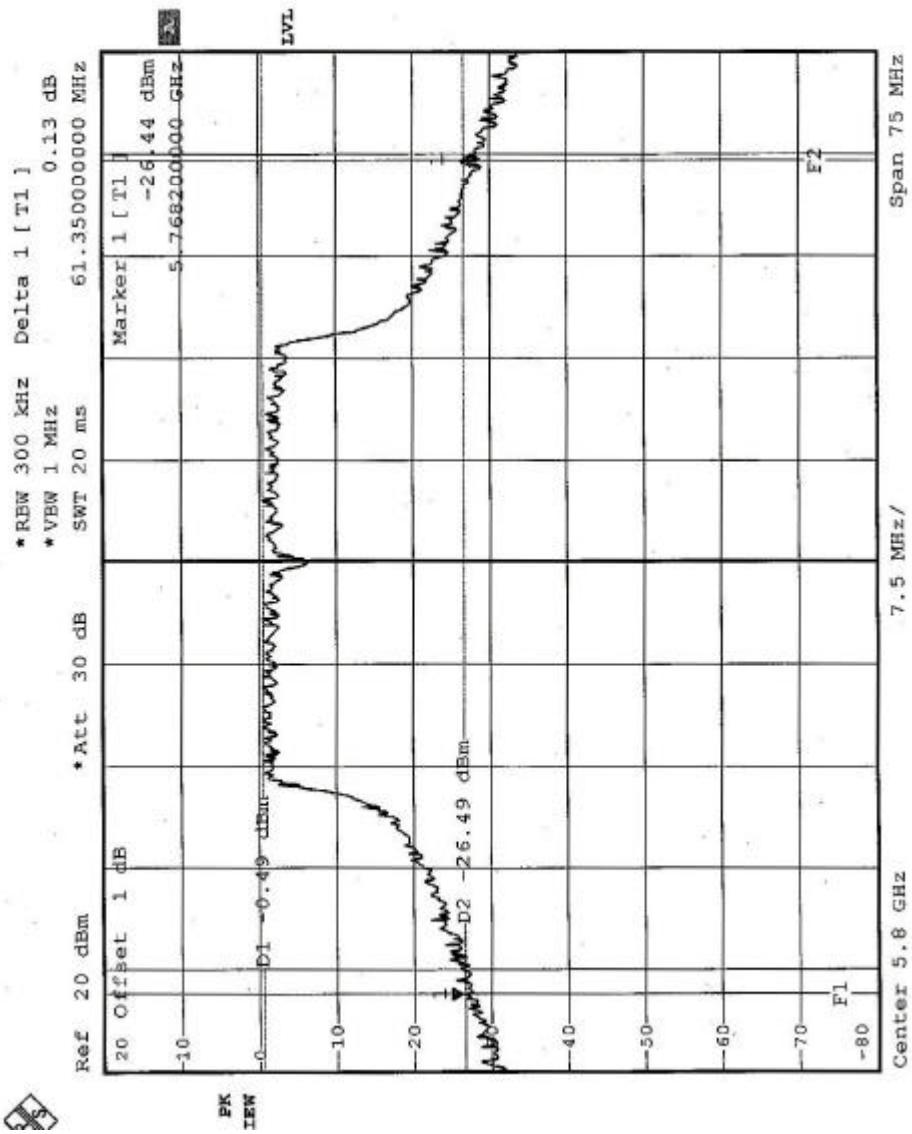
CHANNEL 3



CHANNEL 4



CHANNEL 5



5.4 PEAK POWER EXCURSION MEASUREMENT

5.4.1 LIMITS OF PEAK POWER EXCURSION MEASUREMENT

Frequency Band	Limit
5.15 – 5.25 GHz	13dB
5.25 – 5.35 GHz	13dB
5.725 – 5.825 GHz	13dB

5.4.2 TEST INSTRUMENTS

Description & Manufacturer	Model No.	Serial No.	Calibrated Until
R&S SPECTRUM ANALYZER	FSP30	100019	Dec. 19, 2003

NOTE:

The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.